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#### Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

#### Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Obsolete
Core Processor	PowerPC G2_LE
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	400MHz
Co-Processors/DSP	Communications; RISC CPM, Security; SEC
RAM Controllers	DRAM, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100Mbps (2)
SATA	-
USB	USB 2.0 (1)
Voltage - I/O	3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	516-BBGA
Supplier Device Package	516-PBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8248zqtmfa

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Overview

- One of the FCCs supports ATM (MPC8272 and MPC8271 only)—full-duplex SAR at 155 Mbps, 8-bit UTOPIA interface 31 Mphys, AAL5, AAL1, AAL2, AAL0 protocols, TM 4.0 CBR, VBR, UBR, ABR traffic types, up to 64-K external connections
- Three serial communications controllers (SCCs) identical to those on the MPC860 supporting the digital portions of the following protocols:
  - Ethernet/IEEE 802.3 CDMA/CS
  - HDLC/SDLC and HDLC bus
  - Universal asynchronous receiver transmitter (UART)
  - Synchronous UART
  - Binary synchronous (BiSync) communications
  - Transparent
  - QUICC multichannel controller (QMC) up to 64 channels
    - Independent transmit and receive routing, frame synchronization.
    - Serial-multiplexed (full-duplex) input/output 2048, 1544, and 1536 Kbps PCM highways
    - Compatible with T1/DS1 24-channel and CEPT E1 32-channel PCM highway, ISDN basic rate, ISDN primary rate, and user defined.
    - Subchanneling on each time slot.
    - Independent transmit and receive routing, frame synchronization and clocking
    - Concatenation of any not necessarily consecutive time slots to channels independently for receiver/transmitter
    - Supports H1,H11, and H12 channels
    - Allows dynamic allocation of channels
  - SCC3 in NMSI mode is not usable when USB is enabled.
- Two serial management controllers (SMCs), identical to those of the MPC860
  - Provides management for BRI devices as general-circuit interface (GCI) controllers in time-division-multiplexed (TDM) channels
  - Transparent
  - UART (low-speed operation)
- One serial peripheral interface identical to the MPC860 SPI
- One  $I^2C$  controller (identical to the MPC860  $I^2C$  controller)
  - Microwire compatible
  - Multiple-master, single-master, and slave modes
- Up to two TDM interfaces
  - Supports one groups of two TDM channels
  - 1024 bytes of SI RAM
- Eight independent baud rate generators and 14 input clock pins for supplying clocks to FCC, SCC, SMC, and USB serial channels
- Four independent 16-bit timers that can be interconnected as two 32-bit timers



### **Operating Conditions**

I/O supply voltage

Junction temperature (maximum)

Input voltage

1

This table lists recommended operational voltage conditions.

•	•	
Rating	Symbol	Value
Core supply voltage	VDD	1.425 – 575
PLL supply voltage	VCCSYN	1.425 – 575

VDDH

VIN

Τi

Table 4. Recommended Operating Conditions<sup>1</sup>

 Ambient temperature
 T<sub>A</sub>
 0-70<sup>2</sup>
 °C

 Caution: These are the recommended and tested operating conditions. Proper operation outside of these conditions is not guaranteed.
 State
 State

<sup>2</sup> Note that for extended temperature parts the range is  $(-40)_{T_A} - 105_{T_i}$ .

This SoC contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (either GND or  $V_{CC}$ ).

This figure shows the undershoot and overshoot voltage of the 60x bus memory interface of the SoC. Note that in PCI mode the I/O interface is different.



Figure 2. Overshoot/Undershoot Voltage

Unit

V

V

V

V

°C

3.135 - 3.465

GND (-0.3) - 3.465

105<sup>2</sup>



#### **DC Electrical Characteristics**

Та	b	e	6.	
	~	<b>.</b>	<b>v</b> .	

Characteristic	Symbol	Min	Мах	Unit
I <sub>OI</sub> = 5.3mA	Vol	—	0.4	V
<u>ČŠ</u> [0-9]	0L			
CS(10)/BCTL1				
CS(11)/AP(0)				
BADDR[27-28]				
ALE				
BCTLO				
PWE[0-7]/PSDDQM[0-7]/PBS[0-7]				
PSDA10/PGPL0				
PSDWE/PGPL1				
POE/PSDRAS/PGPL2				
PSDCAS/PGPL3				
PGTA/PUPMWAIT/PGPL4/PPBS				
PSDAMUX/PGPL5				
LWE[0-3]LSDDQM[0-3]/LBS[0-3]/PCI_CFG[0-3]				
LSDA10/LGPL0/PCI MODCKH0				
LSDWE/LGPL1/PCI_MODCKH1				
LOE/LSDRAS/LGPL2/PCI MODCKH2				
LSDCAS/LGPL3/PCI MODCKH3				
LGTA/LUPMWAIT/LGPL4/LPBS				
LSDAMUX/LGPL5/PCI MODCK				
LWR				
MODCK[1-3]/AP[1-3]/TC[0-2]/BNKSEL[0-2]				
$I_{OI} = 3.2 \text{mA}$				
L A14/PAR				
L_A15/FRAME/SMI				
L_A16/TRDY				
L_A17/IRDY/CKSTP_OUT				
L_A18/STOP				
L_A19/DEVSEL				
L_A20/IDSEL				
L_A21/PERR				
L_A22/SERR				
L_A23/REQ0				
L_A24/REQ1/HSEJSW				
L_A25/GNT0				
L_A26/GNT1/HSLED				
L_A27/GNT2/HSENUM				
L_A28/RST/CORE_SRESET				
L_A29/INTAL_A30/REQ2				
L_A31				
LCL_D[0-31)]/AD[0-31]				
LCL_DP[03]/C/BE[0-3]				
PA[0-31]				
PB[4–31]	1			
PC[0-31]	1			
PD[4–31]	1			
TDO	1			
QREQ	1			

TCK,  $\overline{\text{TRST}}$  and  $\overline{\text{PORESET}}$  have min VIH = 2.5V. 1

<sup>2</sup> The leakage current is measured for nominal VDDH,VCCSYN, and VDD.
 <sup>3</sup> V<sub>IL</sub> for IIC interface does not match IIC standard, but does meet IIC standard for V<sub>OL</sub> and should not cause any compatibility issue.



Thermal Characteristics

<sup>4</sup> MPC8280, MPC8275VR, MPC8275ZQ only.

# 4 Thermal Characteristics

This table describes thermal characteristics. See Table 2 for information on a given SoC's package. Discussions of each characteristic are provided in Section 4.1, "Estimation with Junction-to-Ambient Thermal Resistance," through Section 4.7, "References." For the these discussions,  $P_D = (V_{DD} \times I_{DD}) + PI/O$ , where PI/O is the power dissipation of the I/O drivers.

Characteristic	Symbol	Value	Unit	Air Flow	
Junction-to-ambient—	P	27		Natural convection	
single-layer board	κ <sub>θJA</sub>	21	°C/W	1 m/s	
Junction-to-ambient—	R <sub>θJA</sub>	19		Natural convection	
four-layer board		16	°C/W	1 m/s	
Junction-to-board <sup>2</sup>	$R_{ extsf{ heta}JB}$	11	°C/W	—	
Junction-to-case <sup>3</sup>	$R_{ extsf{ heta}JC}$	8	°C/W	_	
Junction-to-package top <sup>4</sup>	$R_{ extsf{ heta}JT}$	2	°C/W	—	

**Table 7. Thermal Characteristics** 

<sup>1</sup> Assumes no thermal vias

<sup>2</sup> Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

<sup>3</sup> Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

<sup>4</sup> Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

## 4.1 Estimation with Junction-to-Ambient Thermal Resistance

An estimation of the chip junction temperature, T<sub>J</sub>, in C can be obtained from the following equation:

$$T_J = T_A + (R_{\theta JA} \times P_D)$$

where:

 $T_A$  = ambient temperature (°C)

 $R_{\theta JA}$  = package junction-to-ambient thermal resistance (°C/W)

 $P_D$  = power dissipation in package

The junction-to-ambient thermal resistance is an industry standard value that provides a quick and easy estimation of thermal performance. However, the answer is only an estimate; test cases have demonstrated that errors of a factor of two (in the quantity  $T_I - T_A$ ) are possible.



**Thermal Characteristics** 

## 4.2 Estimation with Junction-to-Case Thermal Resistance

Historically, the thermal resistance has frequently been expressed as the sum of a junction-to-case thermal resistance and a case-to-ambient thermal resistance:

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$$

where:

 $R_{\theta JA}$  = junction-to-ambient thermal resistance (°C/W)

 $R_{\theta JC}$  = junction-to-case thermal resistance (°C/W)

 $R_{\theta CA}$  = case-to-ambient thermal resistance (°C/W)

 $R_{\theta JC}$  is device related and cannot be influenced by the user. The user adjusts the thermal environment to affect the case-to-ambient thermal resistance,  $R_{\theta CA}$ . For instance, the user can change the air flow around the device, add a heat sink, change the mounting arrangement on the printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device. This thermal model is most useful for ceramic packages with heat sinks where some 90% of the heat flows through the case and the heat sink to the ambient environment. For most packages, a better model is required.

## 4.3 Estimation with Junction-to-Board Thermal Resistance

A simple package thermal model which has demonstrated reasonable accuracy (about 20%) is a two-resistor model consisting of a junction-to-board and a junction-to-case thermal resistance. The junction-to-case thermal resistance covers the situation where a heat sink is used or where a substantial amount of heat is dissipated from the top of the package. The junction-to-board thermal resistance describes the thermal performance when most of the heat is conducted to the printed circuit board. It has been observed that the thermal performance of most plastic packages, especially PBGA packages, is strongly dependent on the board temperature.

If the board temperature is known, an estimate of the junction temperature in the environment can be made using the following equation:

$$T_{J} = T_{B} + (R_{\theta JB} \times P_{D})$$

where:

 $R_{\theta JB}$  = junction-to-board thermal resistance (°C/W)  $T_B$  = board temperature (°C)  $P_D$  = power dissipation in package

If the board temperature is known and the heat loss from the package case to the air can be ignored, acceptable predictions of junction temperature can be made. For this method to work, the board and board mounting must be similar to the test board used to determine the junction-to-board thermal resistance, namely a 2s2p (board with a power and a ground plane) and by attaching the thermal balls to the ground plane.



Thermal Characteristics

# 4.4 Estimation Using Simulation

When the board temperature is not known, a thermal simulation of the application is needed. The simple two-resistor model can be used with the thermal simulation of the application, or a more accurate and complex model of the package can be used in the thermal simulation.

## 4.5 **Experimental Determination**

To determine the junction temperature of the device in the application after prototypes are available, the thermal characterization parameter ( $\Psi_{JT}$ ) can be used to determine the junction temperature with a measurement of the temperature at the top center of the package case using the following equation:

$$T_J = T_T + (\Psi_{JT} \times P_D)$$

where:

 $\Psi_{JT}$  = thermal characterization parameter

 $T_T$  = thermocouple temperature on top of package

 $P_D$  = power dissipation in package

The thermal characterization parameter is measured per JEDEC JESD51-2 specification using a 40-gauge type T thermocouple epoxied to the top center of the package case. The thermocouple should be positioned so that the thermocouple junction rests on the package. A small amount of epoxy is placed over the thermocouple junction and over 1 mm of wire extending from the junction. The thermocouple wire is placed flat against the case to avoid measurement errors caused by cooling effects of the thermocouple wire.

## 4.6 Layout Practices

Each VDD and VDDH pin should be provided with a low-impedance path to the board's power supplies. Each ground pin should likewise be provided with a low-impedance path to ground. The power supply pins drive distinct groups of logic on chip. The VDD and VDDH power supplies should be bypassed to ground using bypass capacitors located as close as possible to the four sides of the package. For filtering high frequency noise, a capacitor of 0.1uF on each VDD and VDDH pin is recommended. Further, for medium frequency noise, a total of 2 capacitors of 47uF for VDD and 2 capacitors of 47uF for VDDH are also recommended. The capacitor leads and associated printed circuit traces connecting to chip VDD, VDDH and ground should be kept to less than half an inch per capacitor lead. Boards should employ separate inner layers for power and GND planes.

All output pins on the SoC have fast rise and fall times. Printed circuit (PC) trace interconnection length should be minimized to minimize overdamped conditions and reflections caused by these fast output switching times. This recommendation particularly applies to the address and data buses. Maximum PC trace lengths of six inches are recommended. Capacitance calculations should consider all device loads as well as parasitic capacitances due to the PC traces. Attention to proper PCB layout and bypassing becomes especially critical in systems with higher capacitive loads because these loads create higher transient currents in the VDD and GND circuits. Pull up all unused inputs or signals that will be inputs during reset. Special care should be taken to minimize the noise levels on the PLL supply pins.



## 4.7 References

Semiconductor Equipment and Materials International(415) 964-5111 805 East Middlefield Rd. Mountain View, CA 94043

MIL-SPEC and EIA/JESD (JEDEC) Specifications800-854-7179 or (Available from Global Engineering Documents)303-397-7956

JEDEC Specifications http://www.jedec.org

- 1. C.E. Triplett and B. Joiner, "An Experimental Characterization of a 272 PBGA Within an Automotive Engine Controller Module," Proceedings of SemiTherm, San Diego, 1998, pp. 47–54.
- 2. B. Joiner and V. Adams, "Measurement and Simulation of Junction to Board Thermal Resistance and Its Application in Thermal Modeling," Proceedings of SemiTherm, San Diego, 1999, pp. 212–220.

# 5 **Power Dissipation**

This table provides preliminary, estimated power dissipation for various configurations. Note that suitable thermal management is required to ensure the junction temperature does not exceed the maximum specified value. Also note that the I/O power should be included when determining whether to use a heat sink. For a complete list of possible clock configurations, see Section 7, "Clock Configuration Modes."

	CPM		CBU		P <sub>INT</sub> (W) <sup>2,3</sup>			
Bus (MHz)	Multiplication	CPM (MHz)	Multiplication Factor	CPU (MHz)	Vddl 1.	I 1.5 Volts		
	1 40101		1 40101		Nominal	Maximum		
66.67	3	200	4	266	1	1.2		
100	2	200	3	300	1.1	1.3		
100	2	200	4	400	1.3	1.5		
133	2	267	3	400	1.5	1.8		

Table 8. Estimated Power Dissipation for Various Configurations<sup>1</sup>

<sup>1</sup> Test temperature =  $105^{\circ}$  C

<sup>2</sup>  $P_{INT} = I_{DD} \times V_{DD}$  Watts

<sup>3</sup> Values do not include I/O. Add the following estimates for active I/O based on the following bus speeds:

66.7 MHz = 0.35 W (nominal), 0.4 W (maximum)

83.3 MHz = 0.4 W (nominal), 0.5 W (maximum)

100 MHz = 0.5 W (nominal), 0.6 W (maximum)

133 MHz = 0.7 W (nominal), 0.8 W (maximum)



AC Electrical Characteristics

# 6 AC Electrical Characteristics

The following sections include illustrations and tables of clock diagrams, signals, and CPM outputs and inputs for 66.67/83.33/100/133 MHz devices. Note that AC timings are based on a 50-pf load for MAX Delay and 10-pf load for MIN delay. Typical output buffer impedances are shown in this table.

Output Buffers	Typical Impedance ( $\Omega$ )
60x bus	45 or 27 <sup>2</sup>
Memory controller	45 or 27 <sup>2</sup>
Parallel I/O	45
PCI	27

<sup>1</sup> These are typical values at 65° C. Impedance may vary by ±25% with process and temperature.

<sup>2</sup> Impedance value is selected through SIUMCR[20,21]. See the SoC reference manual.

## 6.1 CPM AC Characteristics

This table lists CPM output characteristics.

Spec Number		Value (ns)								
Max Min	Characteristic	Maximum Delay				Minimum Delay				
		66 MHz	83 MHz	100 MHz	133 MHz	66 MHz	83 MHz	100 MHz	133 MHz	
sp36a	sp37a	FCC outputs—internal clock (NMSI)	6	5.5	5.5	5.5	0.5	0.5	0.5	0.5
sp36b	sp37b	FCC outputs—external clock (NMSI)	8	8	8	8	2	2	2	2
sp38a	sp39a	SCC/SMC/SPI/I2C outputs—internal clock (NMSI)	10	10	10	10	0	0	0	0
sp38b	sp39b	SCC/SMC/SPI/I2C outputs—external clock (NMSI)	8	8	8	8	2	2	2	2
sp40	sp41	TDM outputs/SI	11	11	11	11	2.5	2.5	2.5	2.5
sp42	sp43	TIMER/IDMA outputs	11	11	11	11	0.5	0.5	0.5	0.5
sp42a	sp43a	PIO outputs	11	11	11	11	0.5	0.5	0.5	0.5

### Table 10. AC Characteristics for CPM Outputs<sup>1</sup>

<sup>1</sup> Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.



This figure shows the SCC/SMC/SPI/I<sup>2</sup>C internal clock.



Note: There are four possible timing conditions for SCC and SPI:

- 1. Input sampled on the rising edge and output driven on the rising edge (shown).
- 2. Input sampled on the rising edge and output driven on the falling edge.
- 3. Input sampled on the falling edge and output driven on the falling edge.
- 4. Input sampled on the falling edge and output driven on the rising edge.

Figure 6. SCC/SMC/SPI/I<sup>2</sup>C Internal Clock Diagram

This figure shows TDM input and output signals.



Note: There are four possible TDM timing conditions:

- 1. Input sampled on the rising edge and output driven on the rising edge (shown).
- 2. Input sampled on the rising edge and output driven on the falling edge.
- 3. Input sampled on the falling edge and output driven on the falling edge.
- 4. Input sampled on the falling edge and output driven on the rising edge.

Figure 7. TDM Signal Diagram



**AC Electrical Characteristics** 

This figure shows signal behavior in MEMC mode.



Figure 10. MEMC Mode Diagram

NOTE

Generally, all SoC bus and system output signals are driven from the rising edge of the input clock (CLKin). Memory controller signals, however, trigger on four points within a CLKin cycle. Each cycle is divided by four internal ticks: T1, T2, T3, and T4. T1 always occurs at the rising edge, and T3 at the falling edge, of CLKin. However, the spacing of T2 and T4 depends on the PLL clock ratio selected, as shown in Table 14.

Table 14.	Tick Spacing for Memory Controller Signals	
-----------	--------------------------------------------	--

PLL Clock Patio	Tick Spacing (T1 Occurs at the Rising Edge of CLKin)					
	Т2	Т3	T4			
1:2, 1:3, 1:4, 1:5, 1:6	1/4 CLKin	1/2 CLKin	3/4 CLKin			
1:2.5	3/10 CLKin	1/2 CLKin	8/10 CLKin			
1:3.5	4/14 CLKin	1/2 CLKin	11/14 CLKin			

This table is a representation of the information in Table 14.



Figure 11. Internal Tick Spacing for Memory Controller Signals



**AC Electrical Characteristics** 

## NOTE

The UPM machine outputs change on the internal tick determined by the memory controller programming; the AC specifications are relative to the internal tick. Note that SDRAM and GPCM machine outputs change on CLKin's rising edge.

## 6.3 JTAG Timings

This table lists the JTAG timings.

Parameter	Symbol <sup>2</sup>	Min	Мах	Unit	Notes
JTAG external clock frequency of operation	f <sub>JTG</sub>	0	33.3	MHz	—
JTAG external clock cycle time	t <sub>JTG</sub>	30	_	ns	—
JTAG external clock pulse width measured at 1.4V	t <sub>JTKHKL</sub>	15	_	ns	—
JTAG external clock rise and fall times	t <sub>JTGR</sub> and t <sub>JTGF</sub>	0	5	ns	6
TRST assert time	t <sub>TRST</sub>	25	_	ns	3, 6
Input setup times Boundary-scan data TMS, TDI	t <sub>JTDVKH</sub> t <sub>JTIVKH</sub>	4 4		ns ns	4,7 4,7
Input hold times Boundary-scan data TMS, TDI	t <sub>JTDXKH</sub> t <sub>JTIXKH</sub>	10 10		ns ns	4 7 4 7
Output valid times Boundary-scan data TDO	t <sub>JTKLDV</sub> t <sub>JTKLOV</sub>		10 10	ns ns	5 7 5 7
Output hold times Boundary-scan data TDO	t <sub>JTKLDX</sub> t <sub>JTKLOX</sub>	1	_	ns ns	5 7 5 7
JTAG external clock to output high impedance Boundary-scan data TDO	t <sub>JTKLDZ</sub> t <sub>JTKLOZ</sub>	1	10 10	ns ns	5,6 5,6

Table 15. JTAG Timings<sup>1</sup>

<sup>I</sup> All outputs are measured from the midpoint voltage of the falling/rising edge of t<sub>TCLK</sub> to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load. Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.

<sup>2</sup> The symbols used for timing specifications herein follow the pattern of t<sub>(first two letters of functional block)(signal)(state) (reference)(state) for inputs and t(<sub>(first two letters of functional block)(reference)(state)(signal)(state) for outputs. For example, t<sub>JTDVKH</sub> symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the t<sub>JTG</sub> clock reference (K) going to the high (H) state or setup time. Also, t<sub>JTDXKH</sub> symbolizes JTAG timing (JT) with respect to the time data input signals (D) went invalid (X) relative to the t<sub>JTG</sub> clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).</sub></sub>

- <sup>3</sup> TRST is an asynchronous level sensitive signal. The setup time is for test purposes only.
- <sup>4</sup> Non-JTAG signal input timing with respect to t<sub>TCLK</sub>.
- <sup>5</sup> Non-JTAG signal output timing with respect to t<sub>TCLK</sub>.
- <sup>6</sup> Guaranteed by design.
- <sup>7</sup> Guaranteed by design and device characterization.

Mode <sup>3</sup>	Bus ( (M	Clock Hz)	CPM Multiplication	CPM (M	Clock Hz)	CPU Multiplication	CPU (M	Clock Hz)	PCI	PCI Clock (MHz)	
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	High	Factor <sup>5</sup>	Low	High	Factor <sup>6</sup>	Low	High
			Defau	ılt Mod	es (MO	DCK_H=0000)	1				
0000_000	60.0	66.7	2	120.0	133.3	2.5	150.0	166.7	2	60.0	66.7
0000_001	50.0	66.7	2	100.0	133.3	3	150.0	200.0	2	50.0	66.7
0000_010	60.0	80.0	2.5	150.0	200.0	3	180.0	240.0	3	50.0	66.7
0000_011	60.0	80.0	2.5	150.0	200.0	3.5	210.0	280.0	3	50.0	66.7
0000_100	60.0	80.0	2.5	150.0	200.0	4	240.0	320.0	3	50.0	66.7
0000_101	50.0	66.7	3	150.0	200.0	3	150.0	200.0	3	50.0	66.7
0000_110	50.0	66.7	3.5	150.0	200.0	3.5	175.0	233.3	3	50.0	66.7
0000_111	50.0	66.7	3	150.0	200.0	4	200.0	266.6	3	50.0	66.7
			F	-ull Cor	nfigurati	on Modes					
0001_000	50.0	66.7	3	150.0	200.0	5	250.0	333.3	3	50.0	66.7
0001_001	50.0	66.7	3	150.0	200.0	6	300.0	400.0	3	50.0	66.7
0001_010	50.0	66.7	3	150.0	200.0	7	350.0	466.6	3	50.0	66.7
0001_011	50.0	66.7	3	150.0	200.0	8	400.0	533.3	3	50.0	66.7
0010_000	50.0	66.7	4	200.0	266.6	5	250.0	333.3	4	50.0	66.7
0010_001	50.0	66.7	4	200.0	266.6	6	300.0	400.0	4	50.0	66.7
0010_010	50.0	66.7	4	200.0	266.6	7	350.0	466.6	4	50.0	66.7
0010_011	50.0	66.7	4	200.0	266.6	8	400.0	533.3	4	50.0	66.7
0010_100	75.0	100.0	4	300.0	400.0	5	375.0	500.0	6	50.0	66.7
0010_101	75.0	100.0	4	300.0	400.0	5.5	412.5	549.9	6	50.0	66.7
0010_110	75.0	100.0	4	300.0	400.0	6	450.0	599.9	6	50.0	66.7
0011_000	50.0	66.7	5	250.0	333.3	5	250.0	333.3	5	50.0	66.7
0011_001	50.0	66.7	5	250.0	333.3	6	300.0	400.0	5	50.0	66.7
0011_010	50.0	66.7	5	250.0	333.3	7	350.0	466.6	5	50.0	66.7
0011_011	50.0	66.7	5	250.0	333.3	8	400.0	533.3	5	50.0	66.7
0100_000						Reserved					

 Table 17. Clock Configurations for PCI Host Mode (PCI\_MODCK=0)<sup>1,2</sup>



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Mode <sup>3</sup>	Bus (M	Clock Hz)	CPM Multiplication	CPM (M	Clock Hz)	CPU	CPU (M	Clock Hz)	PCI	PCI ( (M	Clock Hz)
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	High	Factor <sup>5</sup>	Low	High	Factor <sup>6</sup>	Low	High
0100_001	50.0	66.7	6	300.0	400.0	6	300.0	400.0	6	50.0	66.7
0100_010	50.0	66.7	6	300.0	400.0	7	350.0	466.6	6	50.0	66.7
0100_011	50.0	66.7	6	300.0	400.0	8	400.0	533.3	6	50.0	66.7
0101_000	60.0	66.7	2	120.0	133.3	2.5	150.0	166.7	2	60.0	66.7
0101_001	50.0	66.7	2	100.0	133.3	3	150.0	200.0	2	50.0	66.7
0101_010	50.0	66.7	2	100.0	133.3	3.5	175.0	233.3	2	50.0	66.7
0101_011	50.0	66.7	2	100.0	133.3	4	200.0	266.6	2	50.0	66.7
0101_100	50.0	66.7	2	100.0	133.3	4.5	225.0	300.0	2	50.0	66.7
0101_101	83.3	111.1	3	250.0	333.3	3.5	291.7	388.9	5	50.0	66.7
0101_110	83.3	111.1	3	250.0	333.3	4	333.3	444.4	5	50.0	66.7
0101_111	83.3	111.1	3	250.0	333.3	4.5	375.0	500.0	5	50.0	66.7
0110_000	60.0	80.0	2.5	150.0	200.0	2.5	150.0	200.0	3	50.0	66.7
0110_001	60.0	80.0	2.5	150.0	200.0	3	180.0	240.0	3	50.0	66.7
0110_010	60.0	80.0	2.5	150.0	200.0	3.5	210.0	280.0	3	50.0	66.7
0110_011	60.0	80.0	2.5	150.0	200.0	4	240.0	320.0	3	50.0	66.7
0110_100	60.0	80.0	2.5	150.0	200.0	4.5	270.0	360.0	3	50.0	66.7
0110_101	60.0	80.0	2.5	150.0	200.0	5	300.0	400.0	3	50.0	66.7
0110_110	60.0	80.0	2.5	150.0	200.0	6	360.0	480.0	3	50.0	66.7
0111_000						Reserved					
0111_001	50.0	66.7	3	150.0	200.0	3	150.0	200.0	3	50.0	66.7
0111_010	50.0	66.7	3	150.0	200.0	3.5	175.0	233.3	3	50.0	66.7
0111_011	50.0	66.7	3	150.0	200.0	4	200.0	266.6	3	50.0	66.7
0111_100	50.0	66.7	3	150.0	200.0	4.5	225.0	300.0	3	50.0	66.7
1000_000	Reserved										
1000_001	66.7	88.9	3	200.0	266.6	3	200.0	266.6	4	50.0	66.7

Table 17. CIUCK CUTHIQUIATIONS IN FOURIST MODE (FOURIODORED) (CUTHINGED)	Table 17. Clo	ock Configuration	s for PCI Host Mod	e (PCI MODCK=0	) <sup>1,2</sup> (continued)
--------------------------------------------------------------------------	---------------	-------------------	--------------------	----------------	------------------------------



Table 18. Clock Configurations for PCI Host Mode	(PCI_MODCK=1) <sup>1,2</sup> (continued)
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Mode <sup>3</sup>	Bus ( (MI	Clock Hz)	CPM Multiplication	CPM (M	Clock Hz)	CPU Multiplication	CPU (M	Clock Hz)	PCI	PCI ( (M	Clock Hz)
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	High	Factor <sup>5</sup>	Low	High	Factor <sup>6</sup>	Low	High
1000_010	66.7	133.3	3	200.0	400.0	3.5	233.3	466.7	8	25.0	50.0
1000_011	66.7	133.3	3	200.0	400.0	4	266.7	533.3	8	25.0	50.0
1000_100	66.7	133.3	3	200.0	400.0	4.5	300.0	600.0	8	25.0	50.0
1000_101	66.7	133.3	3	200.0	400.0	6	400.0	800.0	8	25.0	50.0
1000_110	66.7	133.3	3	200.0	400.0	6.5	433.3	866.7	8	25.0	50.0
1001_000		Reserved									
1001_001						Reserved					
1001_010	57.1	114.3	3.5	200.0	400.0	3.5	200.0	400.0	8	25.0	50.0
1001_011	57.1	114.3	3.5	200.0	400.0	4	228.6	457.1	8	25.0	50.0
1001_100	57.1	114.3	3.5	200.0	400.0	4.5	257.1	514.3	8	25.0	50.0
1001_101	42.9	85.7	3.5	150.0	300.0	5	214.3	428.6	6	25.0	50.0
1001_110	42.9	85.7	3.5	150.0	300.0	5.5	235.7	471.4	6	25.0	50.0
1001_111	42.9	85.7	3.5	150.0	300.0	6	257.1	514.3	6	25.0	50.0
1010_000	75.0	150.0	2	150.0	300.0	2	150.0	300.0	6	25.0	50.0
1010_001	75.0	150.0	2	150.0	300.0	2.5	187.5	375.0	6	25.0	50.0
1010_010	75.0	150.0	2	150.0	300.0	3	225.0	450.0	6	25.0	50.0
1010_011	75.0	150.0	2	150.0	300.0	3.5	262.5	525.0	6	25.0	50.0
1010_100	75.0	150.0	2	150.0	300.0	4	300.0	600.0	6	25.0	50.0
1010_101	100.0	200.0	2	200.0	400.0	2.5	250.0	500.0	8	25.0	50.0
1010_110	100.0	200.0	2	200.0	400.0	3	300.0	600.0	8	25.0	50.0
1010_111	100.0	200.0	2	200.0	400.0	3.5	350.0	700.0	8	25.0	50.0
1011_000	Reserved										
1011_001	80.0	160.0	2.5	200.0	400.0	2.5	200.0	400.0	8	25.0	50.0
1011_010	80.0	160.0	2.5	200.0	400.0	3	240.0	480.0	8	25.0	50.0
1011_011	80.0	160.0	2.5	200.0	400.0	3.5	280.0	560.0	8	25.0	50.0
1011_100	80.0	160.0	2.5	200.0	400.0	4	320.0	640.0	8	25.0	50.0



#### **Clock Configuration Modes**

- <sup>6</sup> CPM\_CLK/PCI\_CLK ratio. When PCI\_MODCK = 1, the ratio of CPM\_CLK/PCI\_CLK should be calculated from PCIDF as follows: PCIDF = 3 > CPM\_CLK/PCI\_CLK = 4 PCIDF = 5 > CPM\_CLK/PCI\_CLK = 6 PCIDF = 7 > CPM\_CLK/PCI\_CLK = 8
  - PCIDF = 9 > CPM\_CLK/PCI\_CLK = 5
  - PCIDF = B > CPM\_CLK/PCI\_CLK = 6

## 7.2 PCI Agent Mode

These tables show configurations for PCI agent mode. The frequency values listed are for the purpose of illustration only. Users must select a mode and input bus frequency so that the resulting configuration does not exceed the frequency rating of the user's device. Note that in PCI agent mode the input clock is PCI clock.

Mode <sup>3</sup>	PCI ( (Mi	Clock Hz)	CPM Multiplication	CPM (M	CPM Clock (MHz) CPU Multiplication		CPU Clock (MHz)		Bus	Bus Clock (MHz)		
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	Low High	Factor <sup>5</sup>	Low	High	Factor	Low	High	
Default Modes (MODCK_H=0000)												
0000_000	60.0	66.7	2	120.0	133.3	2.5	150.0	166.7	2	60.0	66.7	
0000_001	50.0	66.7	2	100.0	133.3	3	150.0	200.0	2	50.0	66.7	
0000_010	50.0	66.7	3	150.0	200.0	3	150.0	200.0	3	50.0	66.7	
0000_011	50.0	66.7	3	150.0	200.0	4	200.0	266.6	3	50.0	66.7	
0000_100	50.0	66.7	3	150.0	200.0	3	180.0	240.0	2.5	60.0	80.0	
0000_101	50.0	66.7	3	150.0	200.0	3.5	210.0	280.0	2.5	60.0	80.0	
0000_110	50.0	66.7	4	200.0	266.6	3.5	233.3	311.1	3	66.7	88.9	
0000_111	50.0	66.7	4	200.0	266.6	3	240.0	320.0	2.5	80.0	106.7	
			F	ull Con	figurati	ion Modes						
0001_001	60.0	66.7	2	120.0	133.3	5	150.0	166.7	4	30.0	33.3	
0001_010	50.0	66.7	2	100.0	133.3	6	150.0	200.0	4	25.0	33.3	
0001_011	50.0	66.7	2	100.0	133.3	7	175.0	233.3	4	25.0	33.3	
0001_100	50.0	66.7	2	100.0	133.3	8	200.0	266.6	4	25.0	33.3	
0010_001	50.0	66.7	3	150.0	200.0	3	180.0	240.0	2.5	60.0	80.0	
0010_010	50.0	66.7	3	150.0	200.0	3.5	210.0	280.0	2.5	60.0	80.0	
0010_011	50.0	66.7	3	150.0	200.0	4	240.0	320.0	2.5	60.0	80.0	
0010_100	50.0	66.7	3	150.0	200.0	4.5	270.0	360.0	2.5	60.0	80.0	

Table 19. Clock Configurations for PCI Agent Mode (PCI\_MODCK=0)<sup>1,2</sup>

Mode <sup>3</sup>	PCI ( (MI	Clock Hz)	CPM Multiplication	CPM (M	Clock Hz)	CPU Multiplication	CPU (M	Clock Hz)	Bus Division	Bus Clock (MHz)	
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	High	Factor <sup>5</sup>	Low	High	Factor	Low	High
			Defau	It Mod	es (MO	DCK_H=0000)					
0000_000	30.0	50.0	4	120.0	200.0	2.5	150.0	250.0	2	60.0	100.0
0000_001	25.0	50.0	4	100.0	200.0	3	150.0	300.0	2	50.0	100.0
0000_010	25.0	50.0	6	150.0	300.0	3	150.0	300.0	3	50.0	100.0
0000_011	25.0	50.0	6	150.0	300.0	4	200.0	400.0	3	50.0	100.0
0000_100	25.0	50.0	6	150.0	300.0	3	180.0	360.0	2.5	60.0	120.0
0000_101	25.0	50.0	6	150.0	300.0	3.5	210.0	420.0	2.5	60.0	120.0
0000_110	25.0	50.0	8	200.0	400.0	3.5	233.3	466.7	3	66.7	133.3
0000_111	25.0	50.0	8	200.0	400.0	3	240.0	480.0	2.5	80.0	160.0
			F	-ull Cor	nfigurati	on Modes					
0001_001	30.0	50.0	4	120.0	200.0	5	150.0	250.0	4	30.0	50.0
0001_010	25.0	50.0	4	100.0	200.0	6	150.0	300.0	4	25.0	50.0
0001_011	25.0	50.0	4	100.0	200.0	7	175.0	350.0	4	25.0	50.0
0001_100	25.0	50.0	4	100.0	200.0	8	200.0	400.0	4	25.0	50.0
0010_001	25.0	50.0	6	150.0	300.0	3	180.0	360.0	2.5	60.0	120.0
0010_010	25.0	50.0	6	150.0	300.0	3.5	210.0	420.0	2.5	60.0	120.0
0010_011	25.0	50.0	6	150.0	300.0	4	240.0	480.0	2.5	60.0	120.0
0010_100	25.0	50.0	6	150.0	300.0	4.5	270.0	540.0	2.5	60.0	120.0
0011_000						Reserved					
0011_001	37.5	50.0	4	150.0	200.0	3	150.0	200.0	3	50.0	66.7
0011_010	32.1	50.0	4	128.6	200.0	3.5	150.0	233.3	3	42.9	66.7
0011_011	28.1	50.0	4	112.5	200.0	4	150.0	266.7	3	37.5	66.7
0011_100	25.0	50.0	4	100.0	200.0	4.5	150.0	300.0	3	33.3	66.7
0100_000	Reserved										
0100_001	25.0	50.0	6	150.0	300.0	3	150.0	300.0	3	50.0	100.0
0100_010	25.0	50.0	6	150.0	300.0	3.5	175.0	350.0	3	50.0	100.0
0100_011	25.0	50.0	6	150.0	300.0	4	200.0	400.0	3	50.0	100.0

# Table 20. Clock Configurations for PCI Agent Mode (PCI\_MODCK=1)<sup>1,2</sup>



Mode <sup>3</sup>	PCI ( (M	Clock Hz)	CPM Multiplication	CPM (M	Clock Hz)	CPU	CPU (M	Clock Hz)	Bus	Bus Clock (MHz)	
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	High	Factor <sup>5</sup>	Low	High	Factor	Low	High
0100_100	25.0	50.0	6	150.0	300.0	4.5	225.0	450.0	3	50.0	100.0
0101_000	30.0	50.0	5	150.0	250.0	2.5	150.0	250.0	2.5	60.0	100.0
0101_001	25.0	50.0	5	125.0	250.0	3	150.0	300.0	2.5	50.0	100.0
0101_010	25.0	50.0	5	125.0	250.0	3.5	175.0	350.0	2.5	50.0	100.0
0101_011	25.0	50.0	5	125.0	250.0	4	200.0	400.0	2.5	50.0	100.0
0101_100	25.0	50.0	5	125.0	250.0	4.5	225.0	450.0	2.5	50.0	100.0
0101_101	25.0	50.0	5	125.0	250.0	5	250.0	500.0	2.5	50.0	100.0
0101_110	25.0	50.0	5	125.0	250.0	5.5	275.0	550.0	2.5	50.0	100.0
0110_000						Reserved					
0110_001	25.0	50.0	8	200.0	400.0	3	200.0	400.0	3	66.7	133.3
0110_010	25.0	50.0	8	200.0	400.0	3.5	233.3	466.7	3	66.7	133.3
0110_011	25.0	50.0	8	200.0	400.0	4	266.7	533.3	3	66.7	133.3
0110_100	25.0	50.0	8	200.0	400.0	4.5	300.0	600.0	3	66.7	133.3
0111_000	25.0	50.0	6	150.0	300.0	2	150.0	300.0	2	75.0	150.0
0111_001	25.0	50.0	6	150.0	300.0	2.5	187.5	375.0	2	75.0	150.0
0111_010	25.0	50.0	6	150.0	300.0	3	225.0	450.0	2	75.0	150.0
0111_011	25.0	50.0	6	150.0	300.0	3.5	262.5	525.0	2	75.0	150.0
1000_000						Reserved					
1000_001	25.0	50.0	6	150.0	300.0	2.5	150.0	300.0	2.5	60.0	120.0
1000_010	25.0	50.0	6	150.0	300.0	3	180.0	360.0	2.5	60.0	120.0
1000_011	25.0	50.0	6	150.0	300.0	3.5	210.0	420.0	2.5	60.0	120.0
1000_100	25.0	50.0	6	150.0	300.0	4	240.0	480.0	2.5	60.0	120.0
1000_101	25.0	50.0	6	150.0	300.0	4.5	270.0	540.0	2.5	60.0	120.0
1001_000	Reserved										
1001_001						Reserved					



Mode <sup>3</sup>	PCI ( (MI	Clock Hz)	CPM Multiplication	CPM Clock M (MHz)		CPU Multiplication	CPU Clock (MHz)		Bus Division	Bus Clock (MHz)	
MODCK_H- MODCK[1-3]	Low	High	Factor <sup>4</sup>	Low	High	Factor <sup>5</sup>	Low	High	Factor	Low	High
1110_000	25.0	50.0	5	125.0	250.0	2.5	156.3	312.5	2	62.5	125.0
1110_001	25.0	50.0	5	125.0	250.0	3	187.5	375.0	2	62.5	125.0
1110_010	28.6	50.0	5	142.9	250.0	3.5	250.0	437.5	2	71.4	125.0
1110_011	25.0	50.0	5	125.0	250.0	4	250.0	500.0	2	62.5	125.0
1110_100	25.0	50.0	5	125.0	250.0	4	166.7	333.3	3	41.7	83.3
1110_101	25.0	50.0	5	125.0	250.0	4.5	187.5	375.0	3	41.7	83.3
1110_110	25.0	50.0	5	125.0	250.0	5	208.3	416.7	3	41.7	83.3
1110_111	25.0	50.0	5	125.0	250.0	5.5	229.2	458.3	3	41.7	83.3
1100_000	Reserved										
1100_001	Reserved										
1100_010		Reserved									

### Table 20. Clock Configurations for PCI Agent Mode (PCI\_MODCK=1)<sup>1,2</sup> (continued)

<sup>1</sup> The "low" values are the minimum allowable frequencies for a given clock mode. The minimum bus frequency in a table entry guarantees only the required minimum CPU operating frequency. The "high" values are for the purpose of illustration only. Users must select a mode and input bus frequency so that the resulting configuration does not exceed the frequency rating of the user's device. The minimum CPU frequency is 150 MHz for commercial temperature devices and 175 MHz for extended temperature devices. The minimum CPM frequency is 120 MHz.

<sup>2</sup> PCI\_MODCK determines the PCI clock frequency range. See Table 19 for higher range configurations.

<sup>3</sup> MODCK\_H = hard reset configuration word [28–31] (see Section 5.4 in the SoC reference manual). MODCK[1-3] = three hardware configuration pins.

<sup>4</sup> CPM multiplication factor = CPM clock/bus clock

<sup>5</sup> CPU multiplication factor = Core PLL multiplication factor

# 8 Pinout

This figure and table show the pin assignments and pinout for the 516 PBGA package.



Table 21	Pinout	(continued)	
	. Finout	(continueu)	

Pin N							
MPC8272/MPC8248 and MPC8271/MPC8247	MPC8272/MPC8271 Only	Ball					
	S	D1					
A	A0						
A	A1						
A	A2						
А	3	C6					
A	A4						
А	A6						
А	B6						
А	C7						
А	B7						
А	Α7						
A1	D9						
A1	E11						
A1	2	C9					
A1	3	B9					
A1	4	D11					
A1	5	A9					
A1	6	B10					
A1	7	A10					
A1	8	B11					
A1	9	A11					
A2	20	D12					
A2	21	A12					
A2	22	D13					
A2	23	B13					
A2	24	C13					
A2	A25						
A2	26	B14					
A2	27	D14					
A2	28	E14					
A2	29	A14					



Pin Name		
MPC8272/MPC8248 and MPC8271/MPC8247	MPC8272/MPC8271 Only	Ball
D15		G3
D16		AB3
D17		Y1
D18		T4
D19		Т3
D20		P2
D21		M1
D22		J1
D23		G4
D24		AB2
D25		W4
D26		V2
D27		T1
D28		N5
D29		L1
D30		H1
D31		G5
D32		W5
D33		W2
D34		Т5
D35		Τ2
D36		N1
D37		КЗ
D38		H2
D39		F1
D40		AA2
D41		W1
D42		U3
D43		R2
D44		N2
D45		L2

### Table 21. Pinout (continued)